

Notice of References Cited

Application/Control No.

09/765,378

Applicant(s)/Patent Under
Reexamination
KUROIWA ET AL.

Examiner

Ahshik Kim

Art Unit

2876

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5424523	06-1995	Ohno et al.	
	B	US-5679942	10-1997	Toyoma	235/449
	C	US-			235/449
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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